

<b>Issue Classification</b>	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/840,190	BUCKLEY ET AL.
Examiner	Art Unit	
Huy Q. Phan	2617	

## ISSUE CLASSIFICATION

ORIGINAL		CROSS REFERENCE(S)						
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)					
370	338	370	328	331	332			
INTERNATIONAL CLASSIFICATION		455	432.1	436	437	442		
H	O	4	Q	7	124			
H	O	4	Q	7	120			
				/				
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Huy - PIAN 05/29/07		George Eng 5/25/07						
(Assistant Examiner) (Date)		GEORGE ENG 5/25/07						
J. B. Addy 06/11/07		SUPERVISORY PATENT EXAMINER						
(Legal Instruments Examiner) (Date)		(Primary Examiner)		(Date)		O.G.		O.G.
						Print Claim(s)		Print Fig.
						1		1

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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5	5	35	65	95	125	155	185
6	6	36	66	96	126	156	186
7	7	37	67	97	127	157	187
8	8	38	68	98	128	158	188
9	9	39	69	99	129	159	189
10	10	40	70	100	130	160	190
11	11	41	71	101	131	161	191
12	12	42	72	102	132	162	192
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28		58	88	118	148	178	208
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